Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination SPACCARELLI ET AL.	
10/772,629	SPACCARELLI ET AL		
Examiner	Art Unit		
SANG KIM	3654		

SEARCHED				
Class	Subclass	Date	Examiner	
242	396.6 422.5 422.6 422.9	12/1/2005	SK	
242	571 576 580	12/1/2005	SK	
242	588 588.2	12/1/2005	SK	
24	509 510	12/1/2005	SK	
vodutel	<i>)</i>	4-24-06	SIC	
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ГИІ	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		1.4400.000			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
John Nguyen: 242/396.6,422.5- .6,422.9,571,576,588,588.2 James Brittain: 24/509,510 Text search subclass 499-511	12/1/2005	SK		
Dean Kramer. 294199.2 text	4-24-06	sK		
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